

# Introduction to Micro/Nano Fabrication Techniques

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#### **Fabrication of Nanomaterials**

- Top-Down Approach
  - Begin with bulk materials that are reduced into nanoscale materials
  - Ex: Traditional Machining
- Bottom-Up Approach
  - Begin with atoms and molecules that can grown into zero, one, two, and three-dimensional nanostructures
  - Ex: Chemical Synthesis
- Hybrid
  - Top-Down + Bottom-Up



#### Top-Down Approach

- · Mechanical energy
  - Ball milling, polishing, grinding
- Thermal
  - Annealing, evaporation, pyrolysis
- · High energy
  - Arch, laser, ion milling, reactive ion etching
- Chemical
  - Chemical etching, CMP, electropolishing, anodizing
- Lithographic
  - Photo, e-beam, EUV, X-ray, μ-cp, NIL, Nanosphere
- Nature
  - Erosion, decomposition, digestion



#### Bottom-Up Approach

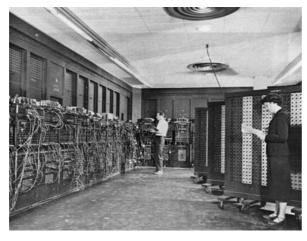
- Gas
  - Chemical vapor deposition, atomic layer deposition, MOCVD, MBE, ion implantation
- Liquid
  - Self-assembly, supermolecule, reduction, template synthesis
- Lithographic
  - Dip-pen, block co-polymer, STM writing
- Biological
  - Protein, nuclear acidcrystal formation







## **Building a Computer**







ENIAC: Electronic Numerical Integrator And Computer, 1946.



## First Integrated Circuit



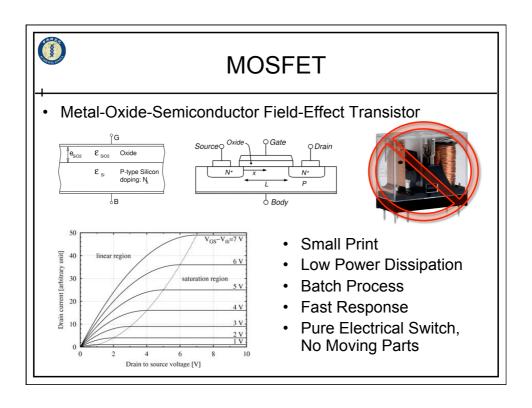


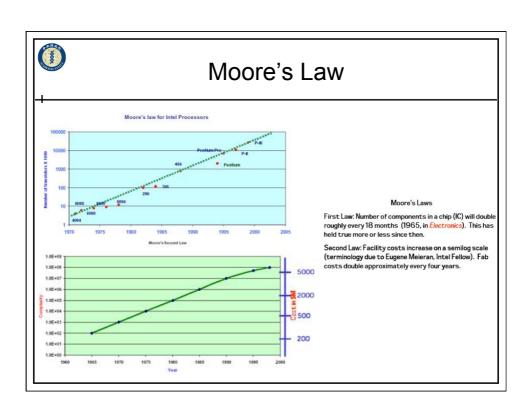


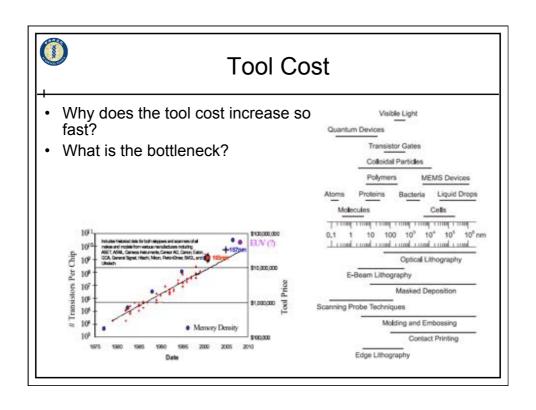
"What we didn't realize then was that the integrated circuit would reduce the cost of electronic functions by a factor of a million to one, nothing had ever done that for anything before" - Jack Kilby 2000 Nobel Prize

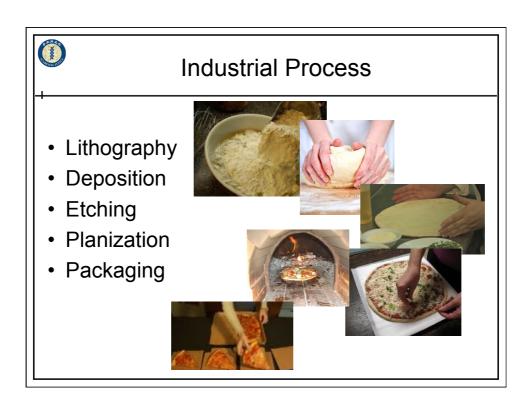


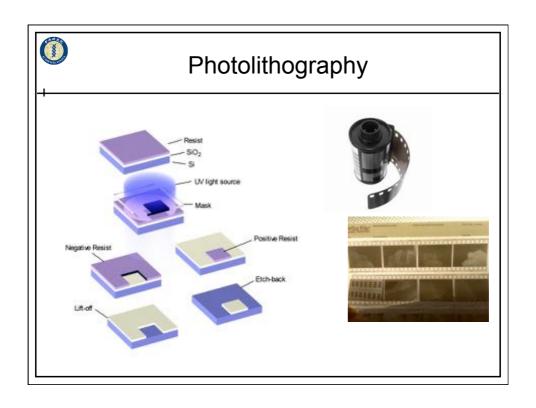


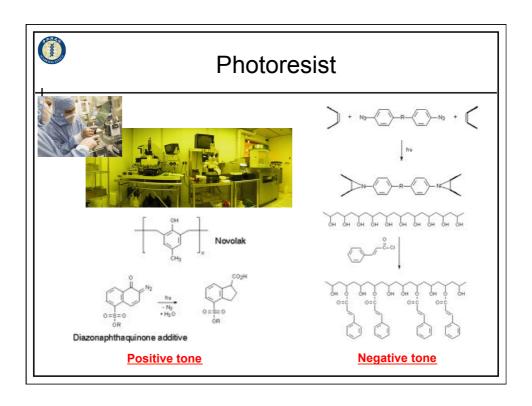




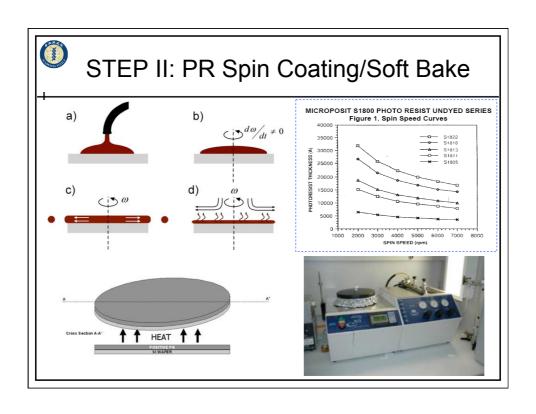


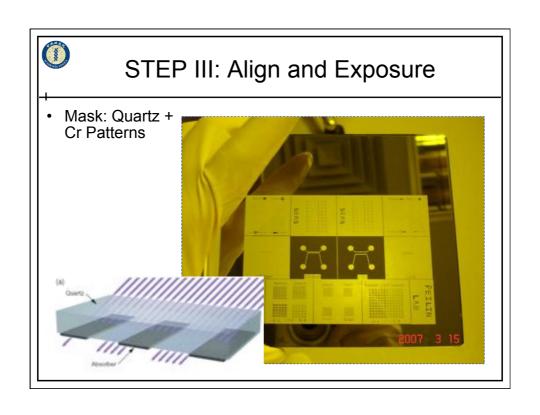


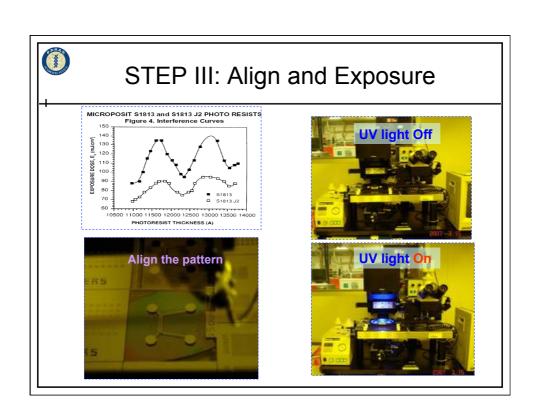




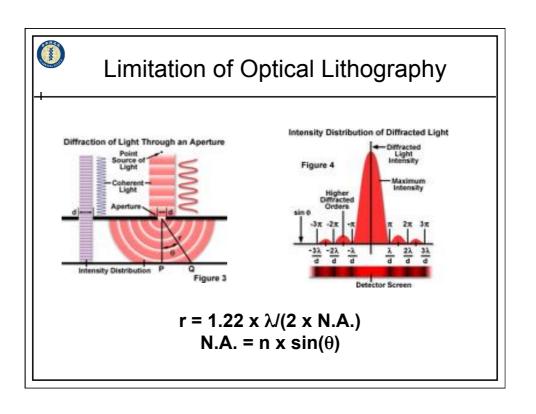
|  |              |                         | eaning                   |                                       |
|--|--------------|-------------------------|--------------------------|---------------------------------------|
| RCA Cleaning   | g (By Ra     | dio Corpo               | ration of Ar             | merica in 1965)                       |
| Chemicals  | Volume ratio | Procedure<br>Time (min) | Operation<br>Temperature | Function                              |
| Trichlorothane   |              | 5                       | Room T                   | Dissolve Organic                      |
| Acetone  |              | 5                       | Room T                   | Dissolve Organic                      |
| DI Water   |              | 5                       | Room T                   | Washing                               |
| H <sub>2</sub> SO <sub>4</sub> (98%)-H <sub>2</sub> O <sub>2</sub> (30%)<br>(Piranha Solution) | 3:1          | 10-20                   | ~90℃                     | Oxide and Dissolve Organic and Metals |
| DI Water   |              | 5                       | Room T                   | Washing                               |
| HF(49 wt %)-H <sub>2</sub> O   | ~2:100       | 10-20                   | Room T                   | Dissolve surface Si0 <sub>2</sub>     |
| NH <sub>4</sub> OH(29%)-H <sub>2</sub> O <sub>2</sub> (30%)-H <sub>2</sub> O                   | 1:1:5        | 10-20                   | ~90℃                     | Oxide and Dissolve Metals             |
| DI Water   |              | 5                       | Room T                   | Washing                               |
| HCI(37%)- H <sub>2</sub> O <sub>2</sub> (30%)-H <sub>2</sub> O                                 | 1:1:5        | 10-20                   | ~90℃                     | Oxide and Dissolve Metals             |
| DI Water   |              | 5                       | Room T                   | Washing                               |
| Spin Dry (In lad – N <sub>2</sub> blow )   |              |                         |                          |                                       |

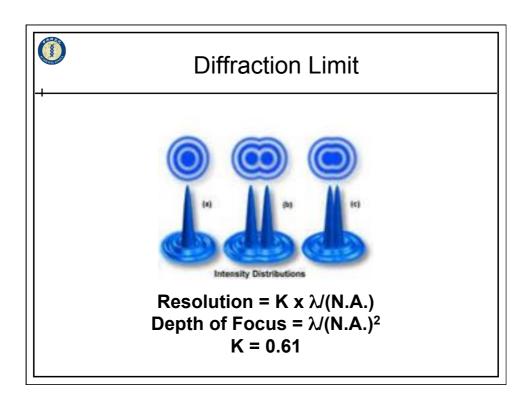


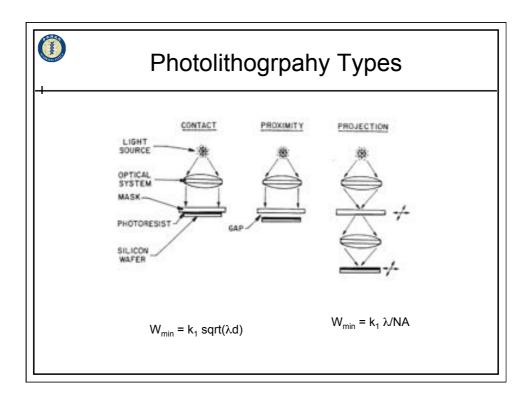


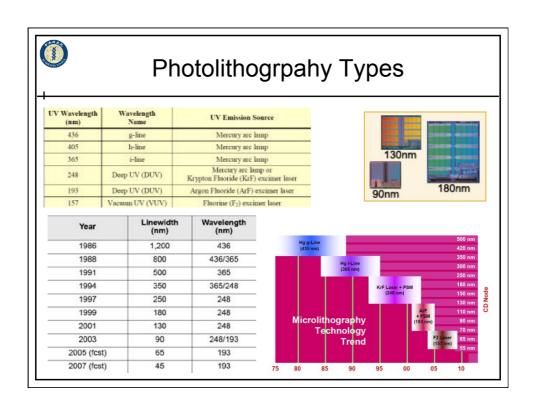














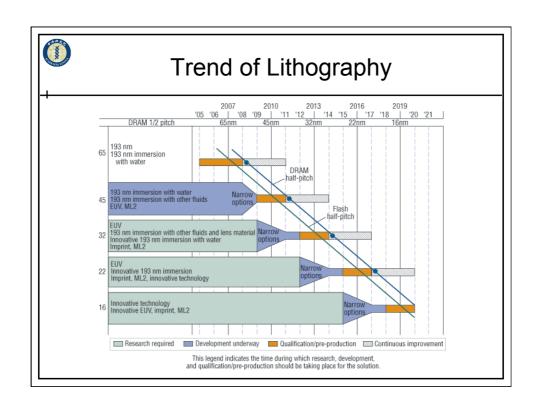
### Water Immersion Lithography

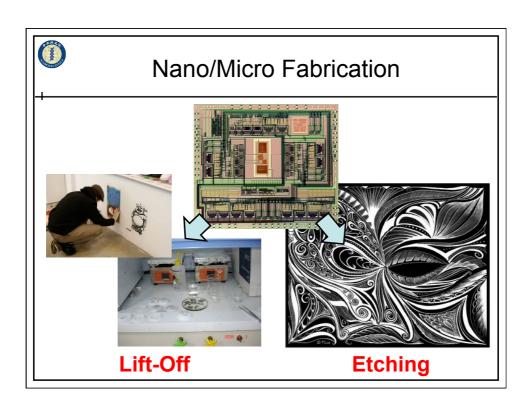
| Year | Linewidth (nm) | Wavelength (nm)         |  |
|------|----------------|-------------------------|--|
| 1986 | 1200           | 436 g-line mercury lamp |  |
| 1988 | 800            | 436/365                 |  |
| 1991 | 500            | 365 i-line mercury lamp |  |
| 1994 | 350            | 365/248                 |  |
| 1997 | 250            | 248 KrF excimer laser   |  |
| 1999 | 180            | 248                     |  |
| 2001 | 130            | 248                     |  |
| 2003 | 90             | 248/193                 |  |
| 2005 | 65             | 193 ArF excimer laser   |  |
| 2007 | 45             | 193/157                 |  |

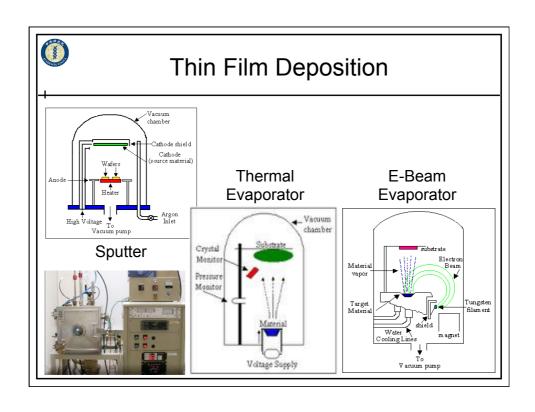
Resolution (R) = K x  $\lambda$ /(N.A.) K = 0.25, NA ~1.4,  $\lambda$  = 193 R = 35 nm

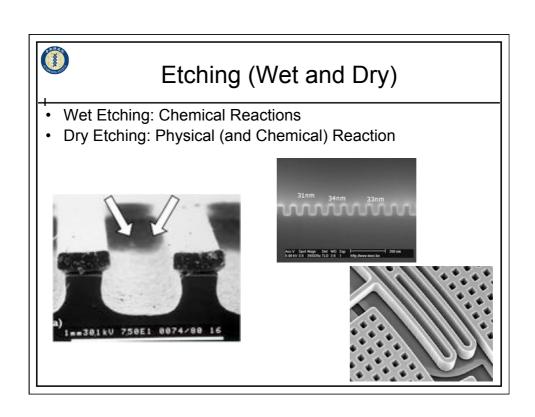
> Air n= 1.0003 Water n = 1.437

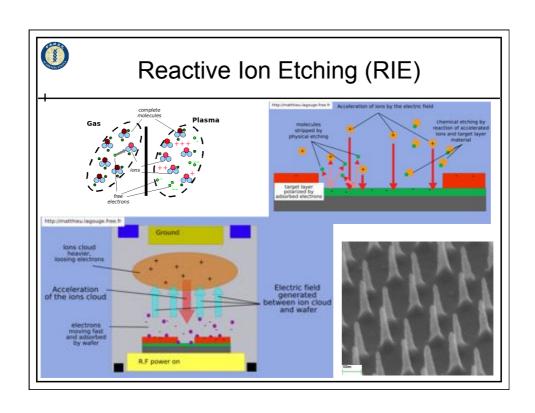
The resolution is increased by a factor equal to the refractive index of the liquid. Current immersion lithography tools use highly purified water for this liquid, achieving feature sizes below 45 nanometers.

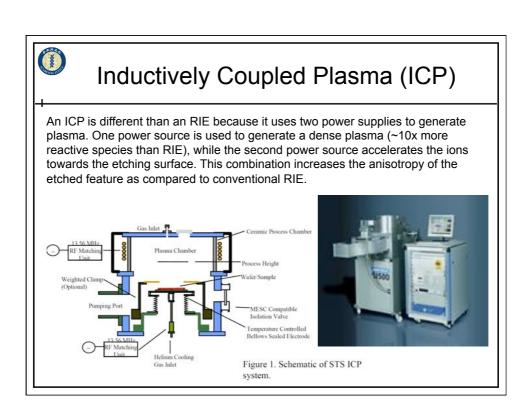


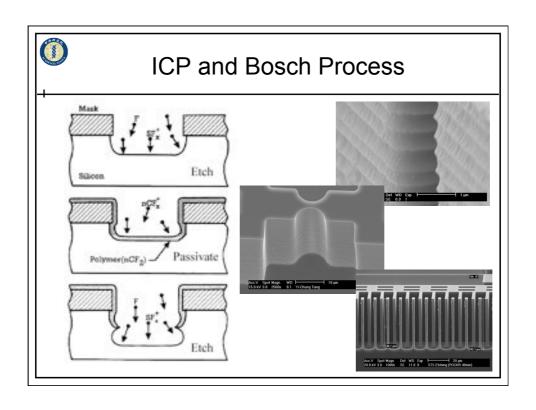


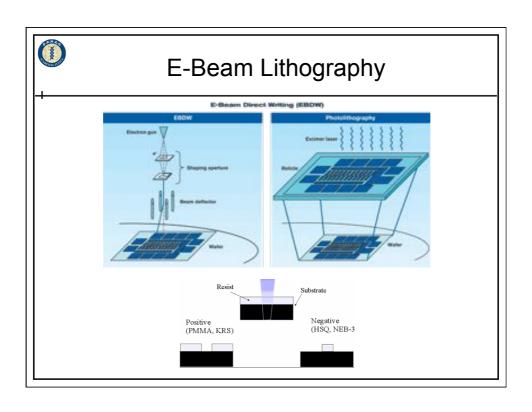


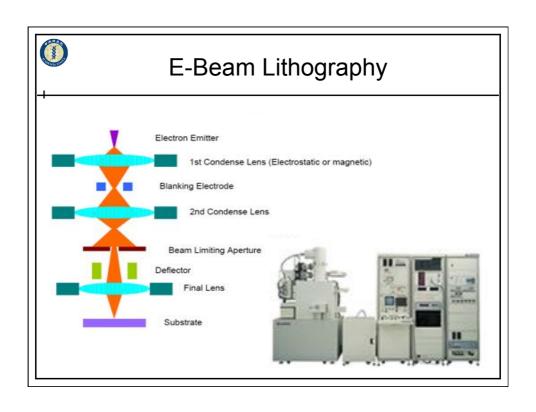


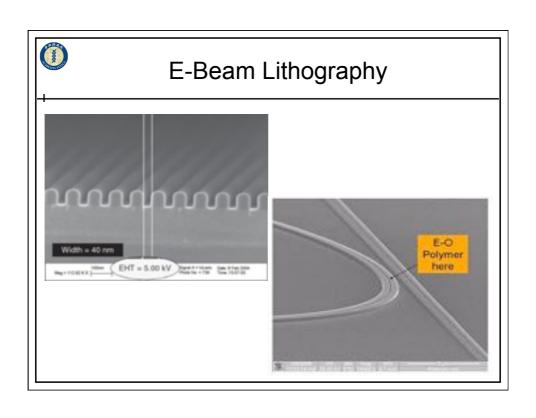


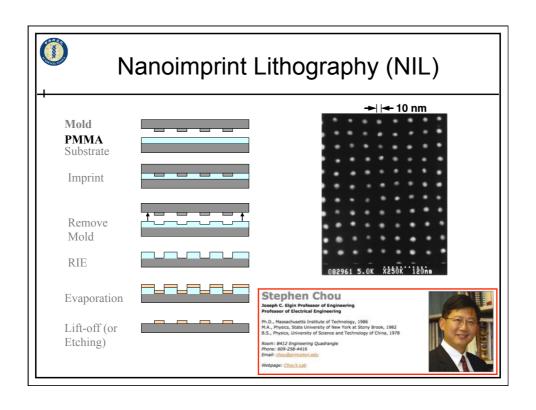


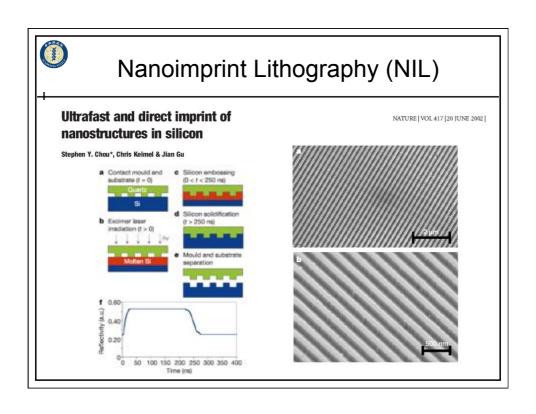


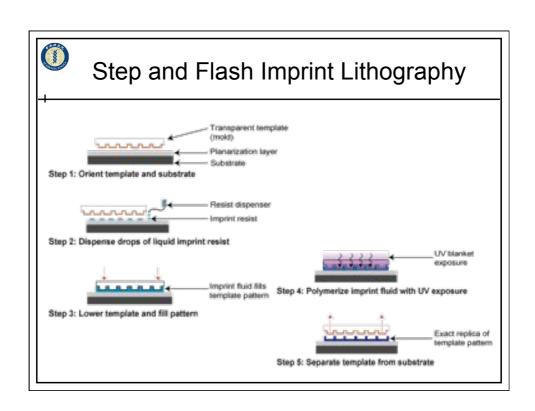


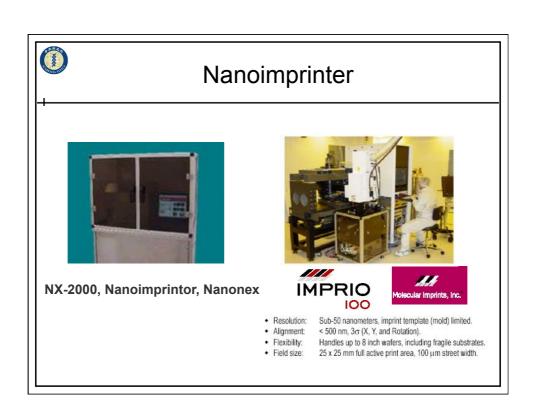














## Nanoimprint Results and Challenge

- Mask Fabrication (1:1)
- Lift-off process
- Resist
- Mask Design

